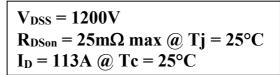
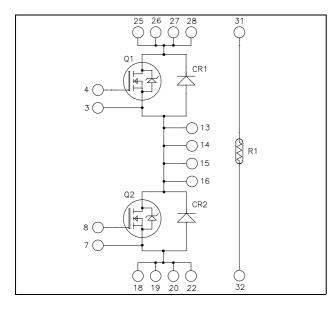


Phase leg SiC MOSFET Power Module





Application

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

Features

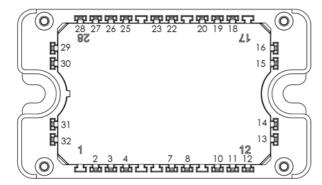
- SiC Power MOSFET
 - High speed switching
 - Low $R_{DS(on)}$
 - Ultra low loss

SiC Schottky Diode

- Zero reverse recovery
- Zero forward recovery
- Temperature Independent switching behavior
- Positive temperature coefficient on VF
- Very low stray inductance
- Kelvin source for easy drive
- Internal thermistor for temperature monitoring
- High level of integration
- AlN substrate for improved thermal performance



- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- RoHS Compliant



Pins 25 to 28 must be shorted together Pins 13 to 16 must be shorted together Pins 18/19/20/22 must be shorted together

All ratings @ $T_i = 25$ °C unless otherwise specified

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

Absolute maximum ratings (per SiC MOSFET)

Symbol	Parameter		Max ratings	Unit
V_{DSS}	Drain - Source Voltage		1200	V
Ţ	Continuous Drain Current	$T_c = 25^{\circ}C$	113	
I _D Continuous Drain Current	Continuous Drain Current	$T_c = 80$ °C	90	A
I_{DM}	Pulsed Drain current		220	
V_{GS}	Gate - Source Voltage		-10/25	V
V_{GSOP}	Gate - Source Voltage, recommended operation values		-5/18	V
R_{DSon}	Drain - Source ON Resistance		25	mΩ
P_{D}	Maximum Power Dissipation	$T_c = 25^{\circ}C$	600	W

Electrical Characteristics (per SiC MOSFET)

Symbol	Characteristic	Test Conditions		Тур	Max	Unit
I_{DSS}	Zero Gate Voltage Drain Current	$V_{GS} = 0V$, $V_{DS} = 1200V$			400	μΑ
R _{DS(on)}	Drain – Source on Resistance	$V_{GS} = 20V; I_D = 80A$ $T_j = 25^{\circ}C$		20	25	O
		$V_{GS} = 18V; I_D = 80A$ $T_j = 175^{\circ}$	C	38.2		mΩ
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 20$ mA	2	2.6	4	V
I_{GSS}	Gate – Source Leakage Current	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$			1	μΑ

Dynamic Characteristics (per SiC MOSFET)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
C_{iss}	Input Capacitance	$V_{GS} = 0V$			3.8		
C_{oss}	Output Capacitance	$V_{DS} = 1000V$			0.32		nF
C_{rss}	Reverse Transfer Capacitance	f = 1MHz			0.030		
Q_{g}	Total gate Charge	$V_{GS} = -5/+20V$			248		
Q_{gs}	Gate – Source Charge	$V_{Bus} = 800V$			60		nC
Q_{gd}	Gate – Drain Charge	$I_D = 80A$			92		
$T_{d(on)}$	Turn-on Delay Time	V = 5/120V			20		
$T_{\rm r}$	Rise Time	$V_{\text{Bus}} = 800\text{V}$	$V_{GS} = -5/+20V$ $V_{Rus} = 800V$		20		
$T_{d(off)} \\$	Turn-off Delay Time	$I_D = 80A ; T_J = 150 ^{\circ}C$			75		ns
T_{f}	Fall Time	$R_{L} = 10\Omega ; R_{Gext} = 1$	2.5Ω		35		
Eon	Turn on Energy	Inductive Switching $V_{GS} = -5/+20V$ $-V_{Bus} = 600V$	$T_j = 150$ °C		1.75		mJ
$E_{\rm off}$	Turn off Energy	$I_{D} = 80A$ $R_{Gext} = 12.5\Omega$	$T_j = 150$ °C		1		1113
R_{Gint}	Internal gate resistance				2.4		Ω
R_{thJC}	Junction to Case Thermal Resistance	ce				0.25	°C/W

Body diode ratings and characteristics (per SiC MOSFET)

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
V_{SD}	Diode Forward Voltage	$V_{GS} = -5V$	$T_j = 25^{\circ}C$		4		V
		$I_{SD} = 40A$	$T_j = 175$ °C		3.5		v
t _{rr}	Reverse Recovery Time	$I_{SD} = 80 A \; ; \; V_{GS} = -5 V \\ V_R = 800 V \; ; \; di_F/dt = 9600 A/\mu s \; . \label{eq:VGS}$			32		ns
Q_{rr}	Reverse Recovery Charge				768		nC
I_{rr}	Reverse Recovery Current				40		A

2 - 8



SiC schottky diode ratings and characteristics (per SiC diode)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
V_{RRM}	Peak Repetitive Reverse Voltage					1200	V
Ĭ	Reverse Leakage Current	V _R =1200V	$T_j = 25$ °C		128 8	800	^
I_{RRM}		V _R -1200 V	$T_j = 175$ °C		224	4000	μA
I_{F}	DC Forward Current		Tc = 125°C		40		A
V_{r}	V_F Diode Forward Voltage $I_F = 40A$	$T_j = T_j$	$T_j = 25$ °C		1.6	1.8	V
V F		IF - 40A	$T_j = 175$ °C		2.3	3	V
Qc	Total Capacitive Charge	$\begin{split} I_F = 40A, \ V_R = 1200V \\ di/dt = 1600A/\mu s \end{split}$			320		nC
С	T + 1 C	$f = 1MHz, V_R =$	$f = 1MHz, V_R = 200V$		384		"F
	Total Capacitance	$f = 1MHz, V_R =$	800V		276		pF
R_{thJC}	Junction to Case Thermal Resistance					0.28	°C/W

Temperature sensor NTC (see application note APT0406 on www.microsemi.com).

Symbol	Characteristic		Min	Typ	Max	Unit
R ₂₅	Resistance @ 25°C			50		kΩ
$\Delta R_{25}/R_{25}$				5		%
$B_{25/85}$	$T_{25} = 298.15 \text{ K}$			3952		K
$\Delta B/B$		T _C =100°C		4		%

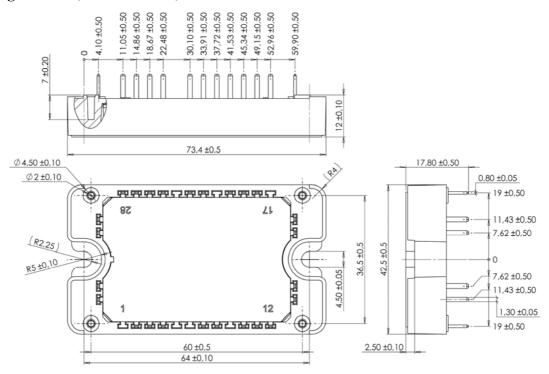
$$R_T = \frac{R_{25}}{\exp \left[B_{25/85} \left(\frac{1}{T_{25}} - \frac{1}{T} \right) \right]} \quad \text{T: Thermistor temperature } \\ R_T: \text{ Thermistor value at T}$$

Thermal and package characteristics

Symbol	Characteristic			Min	Max	Unit
V_{ISOL}	RMS Isolation Voltage, any terminal to case t	=1 min, 50/60H	Z	4000		V
T_{J}	Operating junction temperature range				175	
T_{JOP}	Recommended junction temperature under switching conditions			-40	T _J max -25	°C
T_{STG}	Storage Temperature Range			-40	125	C
$T_{\rm C}$	Operating Case Temperature	-40	125			
Torque	Mounting torque	To heatsink	M4	2	3	N.m
Wt	Package Weight		·		110	g



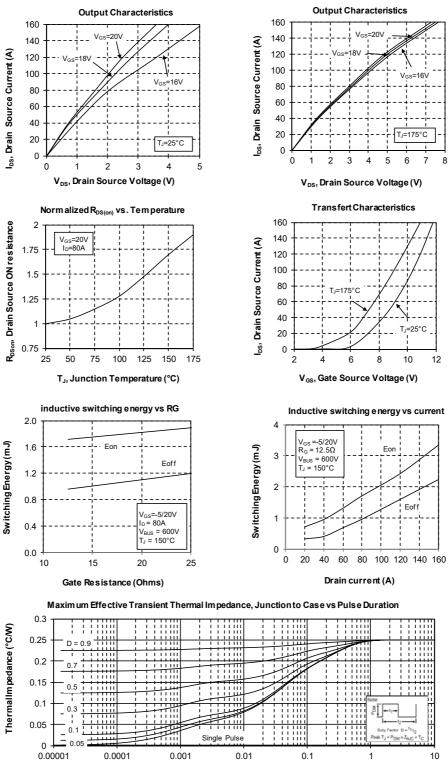
Package outline (dimensions in mm)



See application note 1906 - Mounting Instructions for SP3F Power Modules on www.microsemi.com

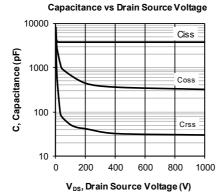


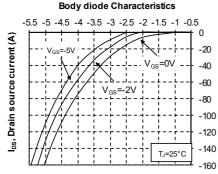
Typical SiC MOSFET Performance Curve



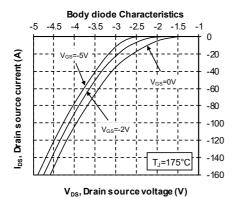
rectangular Pulse Duration (Seconds)

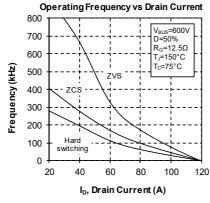




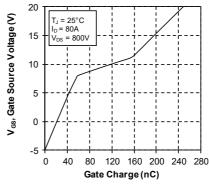


V_{DS}, Drain source voltage (V)

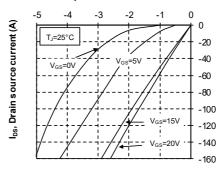




Gate Charge vs Gate Source Voltage

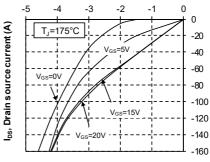


3rd quadrant Characteristics



V_{DS}, Drain source voltage (V)

3rd quadrant Characteristics

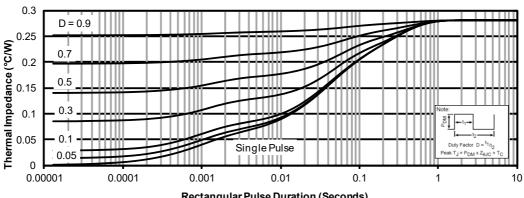


V_{DS}, Drain source voltage (V)

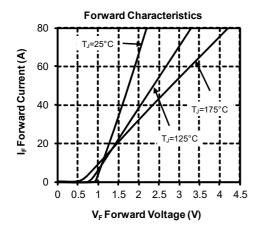


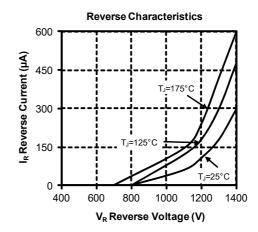
Typical SiC diode Performance Curve

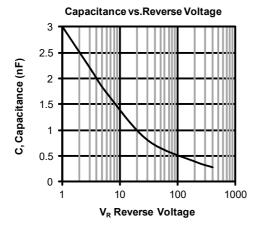
Maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration



Rectangular Pulse Duration (Seconds)









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